

April 1988 Revised September 2000

## 74F112

# **Dual JK Negative Edge-Triggered Flip-Flop**

#### **General Description**

The 74F112 contains two independent, high-speed JK flipflops with Direct Set and Clear inputs. Synchronous state changes are initiated by the falling edge of the clock. Triggering occurs at a voltage level of the clock and is not directly related to the transition time. The J and K inputs can change when the clock is in either state without affecting the flip-flop, provided that they are in the desired state during the recommended setup and hold times relative to the falling edge of the clock. A LOW signal on  $\overline{\mathbb{S}}_{\mathbb{D}}$  or  $\overline{\mathbb{C}}_{\mathbb{D}}$  prevents clocking and forces Q or  $\overline{\mathbb{Q}}$  HIGH, respectively.

Simultaneous LOW signals on  $\overline{S}_D$  and  $\overline{C}_D$  force both Q and  $\overline{Q}$  HIGH.

Asynchronous Inputs:

LOW input to  $\overline{S}_D$  sets Q to HIGH level LOW input to  $\overline{C}_D$  sets Q to LOW level Clear and Set are independent of clock

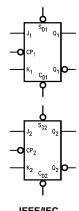
Simultaneous LOW on  $\overline{C}_D$  and  $\overline{S}_D$  makes both Q and  $\overline{Q}$  HIGH

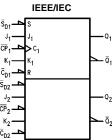
#### **Ordering Code:**

	Order Number	Package Number	Package Description
74F112SJ M16D 16-		M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
		M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
		N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

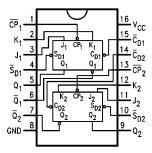
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

## **Logic Symbols**





## **Connection Diagram**



# **Unit Loading/Fan Out**

Din Names	December 1	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>	
Pin Names	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>	
J <sub>1</sub> , J <sub>2</sub> , K <sub>1</sub> , K <sub>2</sub>	Data Inputs	1.0/1.0	20 μA/-0.6 mA	
$\overline{CP}_1$ , $\overline{CP}_2$	Clock Pulse Inputs (Active Falling Edge)	1.0/4.0	20 μA/–2.4 mA	
$\overline{C}_{D1}, \overline{C}_{D2}$	Direct Clear Inputs (Active LOW)	1.0/5.0	20 μA/–3.0 mA	
$\overline{S}_{D1}$ , $\overline{S}_{D2}$	Direct Set Inputs (Active LOW)	1.0/5.0	20 μA/–3.0 mA	
$Q_1, Q_2, \overline{Q}_1, \overline{Q}_2$	Outputs	50/33.3	−1 mA/20 mA	

### **Truth Table**

		Outputs				
$\overline{s}_{D}$	C <sub>D</sub> CP		J	K	Q	Q
L	Н	Х	Х	Χ	Н	L
Н	L	Χ	Х	Χ	L	Н
L	L	Χ	Х	Χ	Н	Н
Н	Н	$\sim$	h	h	$\overline{Q}_0$	$Q_0$
Н	Н	$\sim$	1	h	L	Н
Н	Н	$\sim$	h	1	Н	L
Н	Н	~	I	I	$Q_0$	$\overline{Q}_0$

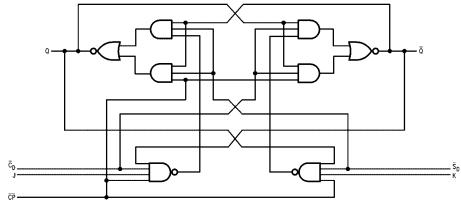
H (h) = HIGH Voltage Level L (l) = LOW Voltage Level X = Immaterial

 $\begin{array}{lll} & & \\ \sim & = \text{HIGH-to-LOW Clock Transition} \\ & & \\$ 

Lower case letters indicate the state of the referenced input or output one setup time prior to the HIGH-to-LOW clock transition.

## **Logic Diagram**

(One Half Shown)



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## **Absolute Maximum Ratings**(Note 1)

-65°C to +150°C Storage Temperature Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias -55°C to +150°C V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0VInput Voltage (Note 2) -0.5V to +7.0VInput Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with  $V_{CC} = 0V$ )

Standard Output -0.5V to  $V_{CC}$ 

3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated I<sub>OL</sub> (mA)

### **Recommended Operating Conditions**

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

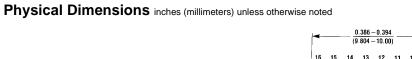
Symbol	Parameter		Min	Тур	Max	Units	V <sub>CC</sub>	Conditions	
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = -18 mA	
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5			V	Min	I <sub>OH</sub> = -1 mA	
	Voltage	5% V <sub>CC</sub>	2.7					$I_{OH} = -1 \text{ mA}$	
V <sub>OL</sub>	Output LOW	10% V <sub>CC</sub>			0.5	V	Min		
	Voltage				0.5	V	IVIII	I <sub>OL</sub> = 20 mA	
I <sub>IH</sub>	Input HIGH				5.0		May	1/ 2.71/	
	Current			5.0	μΑ	Max	$V_{IN} = 2.7V$		
I <sub>BVI</sub>	Input HIGH Current				7.0			7.07	
	Breakdown Test				7.0	μΑ	Max	V <sub>IN</sub> = 7.0V	
I <sub>CEX</sub>	Output HIGH				50		Max		
	Leakage Current				μΑ	IVIAX	V <sub>OUT</sub> = V <sub>CC</sub>		
V <sub>ID</sub>	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9 \mu A$	
	Test		4.73			V	0.0	All other pins grounded	
I <sub>OD</sub>	Output Leakage				3.75	μА	0.0	V <sub>IOD</sub> = 150 mV	
	Circuit Current				3.73	μА	0.0	All other pins grounded	
I <sub>IL</sub>	Input LOW Current				-0.6			$V_{IN} = 0.5V (J_n, K_n)$	
					-2.4	mA	Max	$V_{IN} = 0.5V (\overline{CP}_n)$	
					-3.0			$V_{IN} = 0.5V (\overline{C}_{Dn}, \overline{S}_{Dn})$	
los	Output Short-Circuit Current		-60		-150	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>CCH</sub>	Power Supply Current			12	19	mA	Max	V <sub>O</sub> = HIGH	
I <sub>CCL</sub>	Power Supply Current			12	19	mA	Max	$V_O = LOW$	

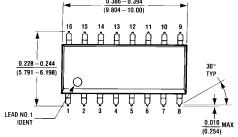
# **AC Electrical Characteristics**

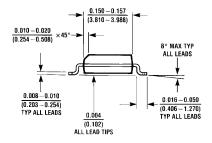
Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units
		Min	Тур	Max	Min	Max	
f <sub>MAX</sub>	Maximum Clock Frequency	85	105		80		MHz
t <sub>PLH</sub>	Propagation Delay	2.0	5.0	6.5	2.0	7.5	no
t <sub>PHL</sub>	$\overline{CP}_{n}$ to $Q_{n}$ or $\overline{Q}_{n}$	2.0	5.0	6.5	2.0	7.5	ns
t <sub>PLH</sub>	Propagation Delay	2.0	4.5	6.5	2.0	7.5	20
t <sub>PHL</sub>	$\overline{C}_{Dn}$ , $\overline{S}_{Dn}$ to $\overline{Q}_n$ , $\overline{Q}_n$	2.0	4.5	6.5	2.0	7.5	ns

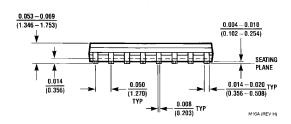
# **AC Operating Requirements**

		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$		Units
Symbol	Parameter					
		Min	Max	Min	Max	
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	4.0		5.0		
t <sub>S</sub> (L)	$J_n$ or $K_n$ to $\overline{CP}_n$	3.0		3.5		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	0		0		115
t <sub>H</sub> (L)	$J_n$ or $K_n$ to $\overline{CP}_n$	0		0		
t <sub>W</sub> (H)	CP Pulse Width	4.5		5.0		ns
t <sub>W</sub> (L)	HIGH or LOW	4.5		5.0		115
t <sub>W</sub> (L)	Pulse Width, LOW $\overline{c}_{Dn}$ or $\overline{S}_{Dn}$	4.5		5.0		ns
t <sub>REC</sub>	Recovery Time $\overline{S}_{Dn}$ , $\overline{C}_{Dn}$ to $\overline{CP}$	4.0		5.0		ns

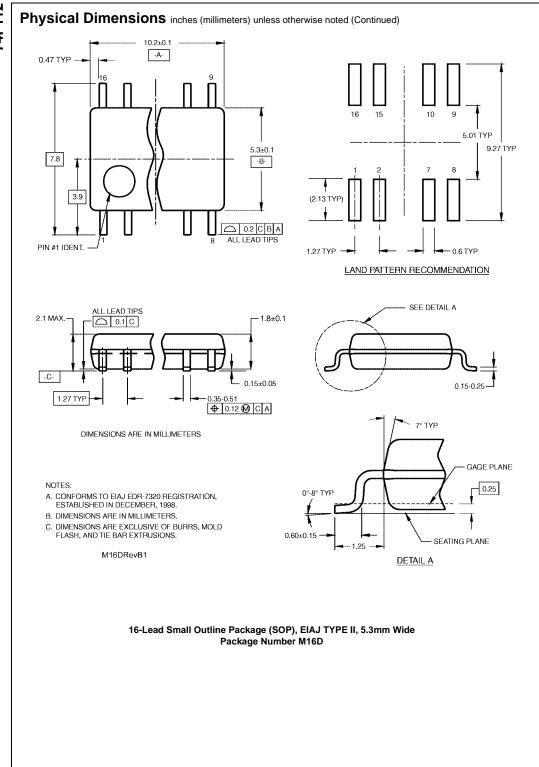


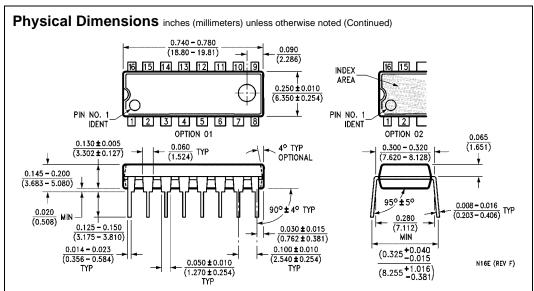






16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow Package Number M16A





16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

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